

Data Sheet March 11, 2008 FN6299.3

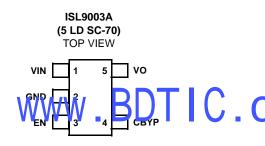
# Low Noise LDO with Low I<sub>Q</sub> and High PSRR

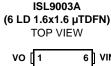
ISL9003A is a high performance single low noise, high PSRR LDO that delivers a continuous 150mA of load current. It has a low standby current and is stable with  $1\mu F$  of MLCC output capacitance with an ESR of up to  $200m\Omega$ .

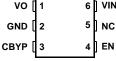
The ISL9003A has a very high PSRR of 90dB and output noise is  $20\mu V_{RMS}$  (typical). When coupled with a no load quiescent current of  $31\mu A$  (typical), and  $0.5\mu A$  shutdown current, the ISL9003A is an ideal choice for portable wireless equipment.

The ISL9003A comes in many fixed voltage options with ±1.8% output voltage accuracy over temperature, line and load. Other output voltage options are available on request.

# **Pinouts**







### **Features**

- High performance LDO with 150mA continuous output
- · Excellent transient response to large current steps
- Excellent load regulation:
   <0.1% voltage change across full range of load current</li>
- Very high PSRR: >90dB @ 1kHz
- Wide input voltage capability: 2.3V to 6.5V
- Extremely low quiescent current: 31µA
- Low dropout voltage: typically 200mV @ 150mA
- Low output noise: typically 20μV<sub>RMS</sub> @ 100μA (1.5V)
- Stable with 1µF to 4.7µF ceramic capacitors
- Shutdown pin turns off LDO with 1µA (max) standby current
- Soft-start limits input current surge during enable
- · Current limit and overheat protection
- ±1.8% accuracy over all operating conditions
- 5 Ld SC-70 package or 6 Ld μTDFN package
- 2-10°C to +85°C operating ten perature lange Pb-free (RoHS compliant)

# **Applications**

- · PDAs, cell phones and smart phones
- Portable instruments, MP3 players
- Handheld devices including medical handhelds

# **Ordering Information**

PART NUMBER (Note 1)	PART MARKING	V <sub>O</sub> VOLTAGE (V) (Note 2)	TEMP. RANGE (°C)	PACKAGE Tape and Reel (Pb-Free)	PKG. DWG. NUMBER
ISL9003AIENZ-T (Note 3)	СВК	3.30	-40 to +85	5 Ld SC-70	P5.049
ISL9003AIEMZ-T (Note 3)	СВЈ	3.00	-40 to +85	5 Ld SC-70	P5.049
ISL9003AIEKZ-T (Note 3)	CCE	2.85	-40 to +85	5 Ld SC-70	P5.049
ISL9003AIEJZ-T (Note 3)	CCD	2.80	-40 to +85	5 Ld SC-70	P5.049
ISL9003AIEHZ-T (Note 3)	ccc	2.75	-40 to +85	5 Ld SC-70	P5.049
ISL9003AIEFZ-T (Note 3)	ССВ	2.50	-40 to +85	5 Ld SC-70	P5.049
ISL9003AIECZ-T (Note 3)	CBY	1.80	-40 to +85	5 Ld SC-70	P5.049
ISL9003AIEBZ-T (Note 3)	CBW	1.50	-40 to +85	5 Ld SC-70	P5.049
ISL9003AIRUBZ-T (Note 3)	L	1.50	-40 to +85	6 Ld μTDFN	L6.1.6x1.6A
ISL9003AIRUCZ-T (Note 4)	G	1.80	-40 to +85	6 Ld μTDFN	L6.1.6x1.6A
ISL9003AIRUFZ-T (Note 4)	F	2.50	-40 to +85	6 Ld μTDFN	L6.1.6x1.6A
ISL9003AIRURZ-T (Note 4)	M2	2.60	-40 to +85	6 Ld μTDFN	L6.1.6x1.6A
ISL9003AIRUHZ-T (Note 4)	Н	2.75	-40 to +85	6 Ld μTDFN	L6.1.6x1.6A
ISL9003AIRUJZ-T (Note 4)	J	2.80	-40 to +85	6 Ld μTDFN	L6.1.6x1.6A
ISL9003AIRUKZ-T (Note 4)	К	2.85	-40 to +85	6 Ld µTDFN	L6.1.6x1.6A
ISL9003AIRUMZ-T (Note 4)	М	3.00	-40 to +85	6 Ld μTDFN	L6.1.6x1.6A
ISL9003AIRUNZ-T (Note 4)	N	3.30	-40 to +85	6 Ld μTDFN	L6.1.6x1.6A

### NOTES:

- 1. Please refer to TB347 for details of the specifications
  2. For other output voltages contact intersil Nark eting COM/ ntersil Nark eting COM/ nters
- These Intersil Pb-free plastic packaged products employ special Pb-free material sets; molding compounds/die attach materials and 100% matte
  tin plate PLUS ANNEAL e3 termination finish, which is RoHS compliant and compatible with both SnPb and Pb-free soldering operations.
  Intersil Pb-free products are MSL classified at Pb-free peak reflow temperatures that meet or exceed the Pb-free requirements of IPC/JEDEC
  J STD-020.
- 4. These Intersil Pb-free plastic packaged products employ special Pb-free material sets; molding compounds/die attach materials and NiPdAu plate e4 termination finish, which is RoHS compliant and compatible with both SnPb and Pb-free soldering operations. Intersil Pb-free products are MSL classified at Pb-free peak reflow temperatures that meet or exceed the Pb-free requirements of IPC/JEDEC J STD-020..

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# **Absolute Maximum Ratings**

Supply Voltage (VIN)	٧
V <sub>O</sub> Pin	۷ć
All Other Pins -0.3V to (VIN + 0.3)	V)

# **Recommended Operating Conditions**

Ambient Temperature Range (T <sub>A</sub> )	40°C to +85°C
Supply Voltage (VIN)	2.3V to 6.5\

# **Thermal Information**

Thermal Resistance	θ <sub>JA</sub> (°C/W)
5 Ld SC-70 Package (Note 5)	231
6 Ld μTDFN Package (Note 6)	125
Junction Temperature Range40°	°C to +125°C
Operating Temperature Range40	0°C to +85°C
Storage Temperature Range 65°	°C to +150°C
Pb-free reflow profile	ee link below
http://www.intersil.com/pbfree/Pb-FreeReflow.asp	

CAUTION: Do not operate at or near the maximum ratings listed for extended periods of time. Exposure to such conditions may adversely impact product reliability and result in failures not covered by warranty.

### NOTE:

- 5. θ<sub>JA</sub> is measured with the component mounted on a high effective thermal conductivity test board in free air. See Tech Brief TB379 for details.
- 6. θ<sub>JA</sub> is measured in free air with the component mounted on a high effective thermal conductivity test board with "direct attach" features. See Tech Brief TB379.

# **Electrical Specifications**

Unless otherwise noted, all parameters are guaranteed over the operational supply voltage and temperature range of the device as follows:  $T_A = -40^{\circ}\text{C}$  to  $+85^{\circ}\text{C}$ ;  $V_{IN} = (V_O + 0.5\text{V})$  to 6.5V with a minimum  $V_{IN}$  of 2.3V;  $C_{IN} = 1\mu\text{F}$ ;  $C_O = 1\mu F$ ;  $C_{BYP} = 0.01\mu F$ 

PARAMETER	SYMBOL	TEST CONDITIONS	MIN (Note 9)	TYP	MAX (Note 9)	UNITS
DC CHARACTERISTICS	I.		<u>I</u>		l.	
Supply Voltage	V <sub>IN</sub>		2.3		6.5	V
Ground Current	I <sub>DD</sub>	Output Enabled; I <sub>O</sub> = 0μA; V <sub>IN</sub> < 4.2V		31	40	μA
		Output Enabled; I <sub>O</sub> = 0μA; Full voltage range			57	μA
Shutdown Current	IDDS	DTIC com/Inte	ro	0.5	1.2	μA
UVLO Threshold VV VV	V <sub>UV+</sub>	DITO.COM/ INTE	1.9	2.	2.3	V
	V <sub>UV-</sub>		1.6	1.8	2.0	V
Regulation Voltage Accuracy		Initial accuracy at $V_{IN} = V_O + 0.5V$ , $I_O = 10$ mA, $T_J = +25$ °C	-0.7		+0.7	%
		$V_{IN} = V_{O} + 0.5V$ to 6.5V, $I_{O} = 10\mu A$ to 150mA, $T_{J} = +25^{\circ} C$	-0.8		+0.8	%
		$V_{IN} = V_O + 0.5V$ to 6.5V, $I_O = 10\mu A$ to 150mA, $T_J = -40^{\circ} C$ to $+125^{\circ} C$	-1.8		+1.8	%
Maximum Output Current	I <sub>MAX</sub>	Continuous	150			mA
Internal Current Limit	I <sub>LIM</sub>		175	265	355	mA
Drop-out Voltage (Note 8)	V <sub>DO1</sub>	I <sub>O</sub> = 150mA; V <sub>O</sub> < 2.5V		300	500	mV
	V <sub>DO2</sub>	$I_O = 150$ mA; $2.5$ V $\leq V_O \leq 2.8$ V		250	400	mV
	V <sub>DO3</sub>	I <sub>O</sub> = 150mA; 2.8V < V <sub>O</sub>		200	325	mV
Thermal Shutdown Temperature	T <sub>SD+</sub>			140		°C
	T <sub>SD-</sub>			110		°C
AC CHARACTERISTICS						
Ripple Rejection (Note 7)		$I_O = 10$ mA, $V_{IN} = 2.8$ V(min), $V_O = 1.8$ V, $C_{BYP} = 0.1$ $\mu$ F				
		@ 1kHz		90		dB
		@ 10kHz		70		dB
		@ 100kHz		50		dB
Output Noise Voltage (Note 7)		$V_O = 1.5V$ , $T_A = +25^{\circ}C$ , $C_{BYP} = 0.1\mu F$				
		BW = 10Hz to 100kHz, $I_0 = 100\mu$ A		20		$\mu V_{RMS}$
		BW = 10Hz to 100kHz, I <sub>O</sub> = 10mA		30		$\mu V_{RMS}$

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# **Electrical Specifications**

Unless otherwise noted, all parameters are guaranteed over the operational supply voltage and temperature range of the device as follows:  $T_A = -40^{\circ}C$  to  $+85^{\circ}C$ ;  $V_{IN} = (V_O + 0.5V)$  to 6.5V with a minimum  $V_{IN}$  of 2.3V;  $C_{IN} = 1\mu F$ ;  $C_O = 1\mu F$ ;  $C_{BYP} = 0.01\mu F$  (Continued)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN (Note 9)	TYP	MAX (Note 9)	UNITS	
DEVICE START-UP CHARACTE	DEVICE START-UP CHARACTERISTICS						
Device Enable tIme	t <sub>EN</sub>	Time from assertion of the EN pin to when the output voltage reaches 95% of the $V_{\rm O}({\rm nom})$ .		250	500	μs	
LDO Soft-start Ramp Rate	tssr	Slope of linear portion of LDO output voltage ramp during start-up		30	60	μs/V	
EN PIN CHARACTERISTICS	EN PIN CHARACTERISTICS						
Input Low Voltage	V <sub>IL</sub>		-0.3		0.4	V	
Input High Voltage	V <sub>IH</sub>		1.4		V <sub>IN</sub> + 0.3	V	
Input Leakage Current	I <sub>IL</sub> , I <sub>IH</sub>				0.1	μA	
Pin Capacitance	C <sub>PIN</sub>	Informative		5		pF	

### NOTES:

- 7. Limits established by characterization and are not production tested.
- 8.  $V_O = 0.98 * V_O(NOM)$ ; Valid for  $V_O$  greater than 1.85V.
- 9. Parts are 100% tested at +25°C. Temperature limits established by characterization and are not production tested

# **Typical Performance Curves**

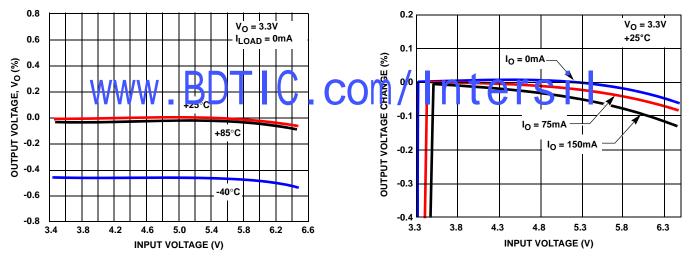


FIGURE 1. OUTPUT VOLTAGE vs INPUT VOLTAGE (3.3V OUTPUT)

FIGURE 2. OUTPUT VOLTAGECHANGE (%) vs INPUT VOLTAGE (3.3V OUTPUT)

# Typical Performance Curves (Continued)

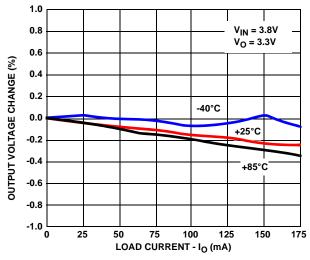


FIGURE 3. OUTPUT VOLTAGE vs LOAD CURRENT

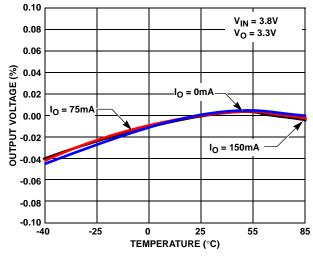


FIGURE 4. OUTPUT VOLTAGE vs TEMPERATURE

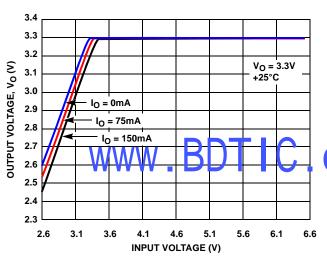


FIGURE 5. DROPOUT VOLTAGE vs INPUT VOLTAGE (3.3V OUTPUT)

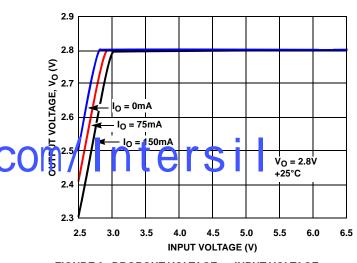


FIGURE 6. DROPOUT VOLTAGE vs INPUT VOLTAGE (2.8V OUTPUT)

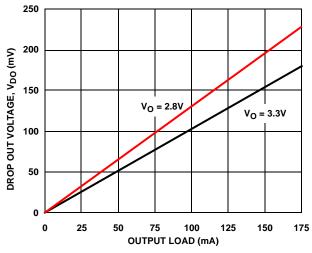


FIGURE 7. DROPOUT VOLTAGE vs LOAD CURRENT

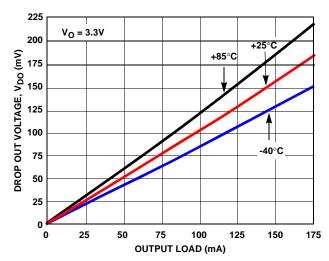
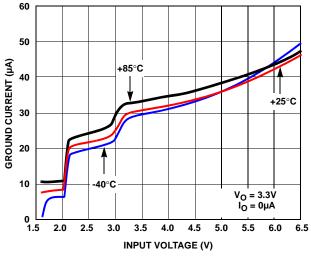


FIGURE 8. DROPOUT VOLTAGE vs LOAD CURRENT

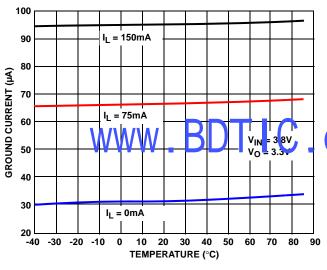
# Typical Performance Curves (Continued)



140 V<sub>IN</sub> = 3.8V  $V_0 = 3.3V$ 120 GROUND CURRENT (µA) 7 9 8 00 +85°C 20 -40°C 0 25 50 75 100 125 150 175 LOAD CURRENT (mA)

FIGURE 9. GROUND CURRENT vs INPUT VOLTAGE





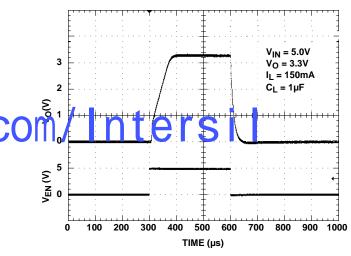
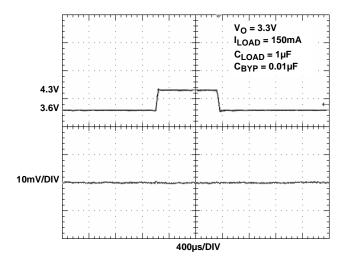


FIGURE 11. GROUND CURRENT vs TEMPERATURE

FIGURE 12. TURN ON/TURN OFF RESPONSE



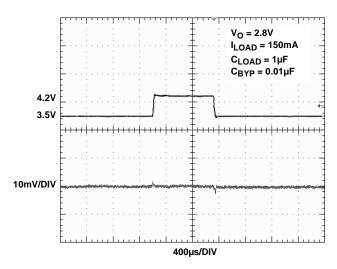


FIGURE 13. LINE TRANSIENT RESPONSE, 3.3V OUTPUT

FIGURE 14. LINE TRANSIENT RESPONSE, 2.8V OUTPUT

# Typical Performance Curves (Continued)

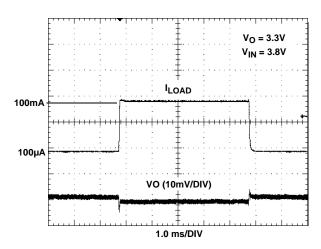


FIGURE 15. LOAD TRANSIENT RESPONSE

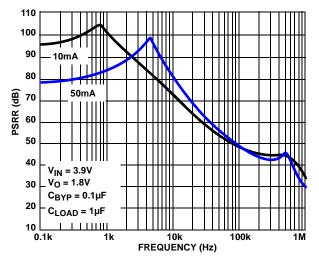


FIGURE 16. PSRR vs FREQUENCY

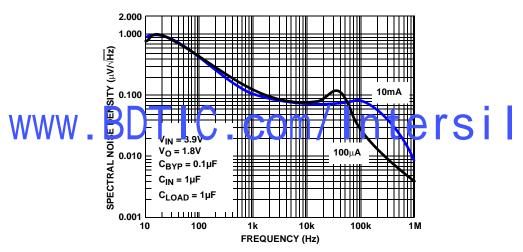
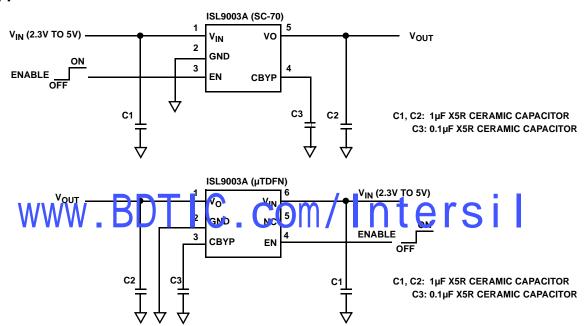


FIGURE 17. SPECTRAL NOISE DENSITY vs FREQUENCY

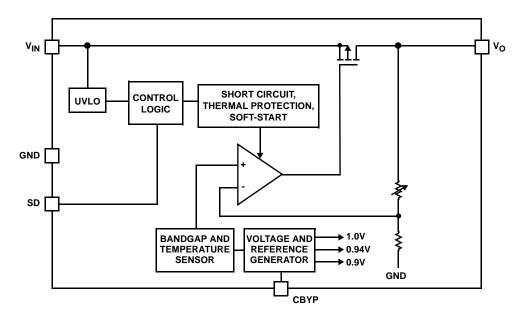
# Pin Description

5 LD SC-70 PIN NUMBER	6 LD µTDFN PIN NUMTBER	PIN NAME	DESCRIPTION
1	6	V <sub>IN</sub>	Supply Voltage/LDO Input. Connect a 1µF capacitor to GND.
2	2	GND	GND is the connection to system ground. Connect to PCB Ground plane.
3	4	EN	Output Enable. When this signal goes high, the LDO is turned on.
4	3	СВҮР	Reference Bypass Capacitor Pin. Optionally connect capacitor of value $0.01\mu F$ to $1\mu F$ between this pin and GND to tune in the desired noise and PSRR performance.
5	1	Vo	LDO Output. Connect a 1µF capacitor of value to GND.
-	5	NC	No Connect.

# Typical Application



# **Block Diagram**



# Functional Description

The ISL9003A contains all circuitry required to implement a high performance LDO. High performance is achieved through a circuit that delivers fast transient response to varying load conditions. In a quiescent condition, the ISL9003A adjusts as playing to achieve the Ic west sandby current consumption.

The device also integrates current limit protection, smart thermal shutdown protection, and soft-start. Smart Thermal shutdown protects the device against overheating. Soft-start minimizes start-up input current surges without causing excessive device turn-on time.

# **Power Control**

The ISL9003A has an enable pin, (EN), to control power to the LDO output. When EN is low, the device is in shutdown mode. In this condition, all on-chip circuits are off, and the device draws minimum current, typically less than 0.3µA. When the EN pin goes high, the device first polls the output of the UVLO detector to ensure that VIN voltage is at least 2.1V (typical). Once verified, the device initiates a start-up sequence. During the start-up sequence, trim settings are first read and latched. Then, sequentially, the bandgap, reference voltage and current generation circuitry turn-on. Once the references are stable, the LDO powers-up.

During operation, whenever the VIN voltage drops below about 1.84V, the ISL9003A immediately disables the LDO output. When VIN rises back above 2.1V (assuming the EN pin is high), the device re-initiates its start-up sequence and LDO operation resumes automatically.

### Reference Generation

The reference generation circuitry includes a trimmed bandgap, a trimmed voltage reference divider, a trimmed current reference generator, and an RC noise filter. The filter includes the external capacitor connected to the CBYP pin. NO 01 JF capacitor connected to the CBYP pin. NO 01 JF capacitor connected CDYP implements a 100Hz owpass fill er, and it recommended for most high performance applications. For the lowest noise application, a 0.1 µF or greater CBYP capacitor should be used. This filters the reference noise to below the 10Hz to 1kHz frequency band, which is crucial in many noise-sensitive applications.

The bandgap generates a zero temperature coefficient (TC) voltage for the regulator reference and other voltage references required for current generation and overtemperature detection.

A current generator provides references required for adaptive biasing as well as references for LDO output current limit and thermal shutdown determination.

# LDO Regulation and Programmable Output Divider

The LDO Regulator is implemented with a high-gain operational amplifier driving a PMOS pass transistor. The design of the ISL9003A provides a regulator that has low quiescent current, fast transient response, and overall stability across all operating and load current conditions. LDO stability is guaranteed for a  $1\mu F$  to  $4.7\mu F$  output capacitor that has a tolerance better than 20% and ESR less than  $200m\Omega$ . The design is performance-optimized for a  $1\mu F$  capacitor. Unless limited by the application, use of an output capacitor value above  $4.7\mu F$  is not recommended as LDO performance improvement is minimal. Soft-start circuitry integrated into each LDO limits the initial ramp-up rate to

about  $30\mu$ s/V to minimize current surge. The ISL9003A provides short-circuit protection by limiting the output current to about 265mA (typ).

The LDO uses an independently trimmed 1V reference as its input. An internal resistor divider drops the LDO output voltage down to 1V. This is compared to the 1V reference for regulation. The resistor division ratio is programmed in the factory.

### **Overheat Detection**

The bandgap outputs a proportional-to-temperature current that is indicative of the temperature of the silicon. This current is compared with references to determine if the device is in danger of damage due to overheating. When the die temperature reaches about +140°C, the LDO momentarily shuts down until the die cools sufficiently. In the overheat condition, if the LDO sources more than 50mA it will be shut off. Once the die temperature falls back below about +110°C, the disabled LDO is re-enabled and soft-start automatically takes place.

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# Small Outline Transistor Plastic Packages (SC70-5)

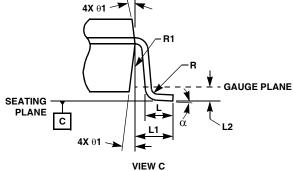
# VIEW C e1 1 2 3 4 SEATING PLANE C-C O.10 (0.004) C BASE METAL

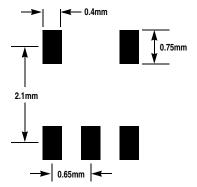
# P5.049 5 LEAD SMALL OUTLINE TRANSISTOR PLASTIC PACKAGE

	INC	HES	MILLIM	ETERS	
SYMBOL	MIN	MAX	MIN	MAX	NOTES
Α	0.031	0.043	0.80	1.10	-
A1	0.000	0.004	0.00	0.10	-
A2	0.031	0.039	0.80	1.00	-
b	0.006	0.012	0.15	0.30	-
b1	0.006	0.010	0.15	0.25	
С	0.003	0.009	0.08	0.22	6
c1	0.003	0.009	0.08	0.20	6
D	0.073	0.085	1.85	2.15	3
E	0.071	0.094	1.80	2.40	-
E1	0.045	0.053	1.15	1.35	3
е	0.025	6 Ref	0.65 Ref		-
e1	0.051	2 Ref	1.30	Ref	-
L	0.010	0.018	0.26	0.46	4
L1	0.017	Ref.	0.420	Ref.	-
L2	0.006	BSC	0.15 BSC		
α	0°	8 <sup>o</sup>	0°	8 <sup>o</sup>	-
N	5		Ę	5	5
R,	0.004	-	0.10	-	
MR1	0.004	0.710	<b>Q</b> .15	0.25	
' <del>                                      </del>			J	F	Rev. 3 7/07

# NOTES:

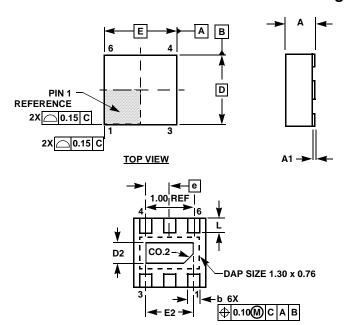
- 1. Dimensioning and tolerances per ASME Y14.5M-1994.
- 2. Package conforms to EIAJ SC70 and JEDEC MO-203AA.
- 3. Dimensions D and E1 are exclusive of mold flash, protrusions, or gate burrs.
- 4. Footlength L measured at reference to gauge plane.
- 5. "N" is the number of terminal positions.
- 6. These Dimensions apply to the flat section of the lead between 0.08mm and 0.15mm from the lead tip.
- 7. Controlling dimension: MILLIMETER. Converted inch dimensions are for reference only.

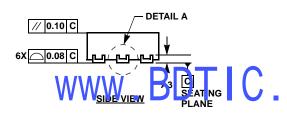




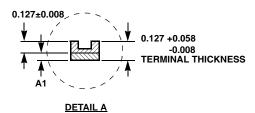
TYPICAL RECOMMENDED LAND PATTERN

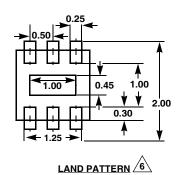
# Ultra Thin Dual Flat No-Lead Plastic Package (UTDFN)





**BOTTOM VIEW** 





# L6.1.6x1.6A 6 LEAD ULTRA THIN DUAL FLAT NO-LEAD PLASTIC PACKAGE

	N			
SYMBOL	MIN	NOTES		
А	0.45	0.50	0.55	-
A1	-	0.05	-	
А3		-		
b	0.15	0.20	0.25	-
D	1.55	1.60	1.65	4
D2	0.40	0.45	0.50	-
Е	1.55	1.60	1.65	4
E2	0.95	1.00	1.05	-
е	0.50 BSC			-
L,	0.25 0.30 0.35			-

Rev. 1 6/06

### NOTES:

- 1. Dimensions are in mm. Angles in degrees.
- Coplanarity applies to the exposed pad as well as the terminals. Coplanarity shall not exceed 0.08mm.
- 3. Warpage shall not exceed 0.10mm.
- Package length/package width are considered as special characteristics.

6. For additional information, to assist with the PCB Land Pattern Design effort, see Intersil Technical Brief TB389.

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